

## N-Channel MOSFET

**Lead Free Package and Finish**

### Applications:

- Adaptor
- Charger
- SMPS

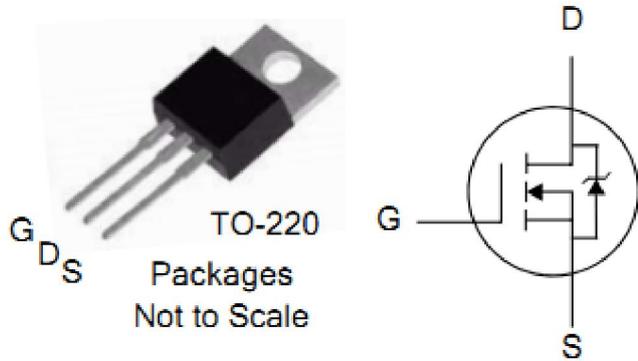
|           |                    |       |
|-----------|--------------------|-------|
| $V_{DSS}$ | $R_{DS(ON)}(Typ.)$ | $I_D$ |
| 200V      | 0.12Ω              | 18A   |

### Features:

- RoHS Compliant
- Low ON Resistance
- Low Gate Charge
- Peak Current vs Pulse Width Curve
- Inductive Switching Curves

### Ordering Information

| PART NUMBER | PACKAGE | BRAND      |
|-------------|---------|------------|
| FTP18N20R   | TO-220  | <b>IPS</b> |



### Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

| Symbol              | Parameter  | FTP18N20R       | Units               |
|---------------------|--|-----------------|---------------------|
| $V_{DSS}$           | Drain-to-Source Voltage                            | 200             | V                   |
| $I_D$               | Continuous Drain Current                           | 18              | A                   |
|                     | Continuous Drain Current $T_C = 100^\circ\text{C}$ | 11.3            | A                   |
| $I_{DM}$            | Pulsed Drain Current (NOTE *1)                     | 72              | A                   |
| $P_D$               | Power Dissipation                                  | 100             | W                   |
|                     | Derating Factor above $25^\circ\text{C}$           | 0.8             | W/ $^\circ\text{C}$ |
| $V_{GS}$            | Gate-to-Source Voltage                             | $\pm 30$        | V                   |
| $E_{AS}$            | Single Pulse Avalanche Energy(NOTE *2)             | 500             | mJ                  |
| dv/dt               | Peak Diode Recovery dv/dt(NOTE *3)                 | 5               | V/ns                |
| $T_L$               | Maximum Temperature for Soldering                  | 300             | $^\circ\text{C}$    |
| $T_J$ and $T_{STG}$ | Operating Junction and Storage Temperature Range   | 150, -55 to 150 |                     |

### Thermal Resistance

| Symbol          | Parameter           | Max. | Units                     | Test Conditions   |
|-----------------|---------------------|------|---------------------------|---|
| $R_{\theta JC}$ | Junction-to-Case    | 1.25 | $^\circ\text{C}/\text{W}$ | Water cooled heatsink, $P_D$ adjusted for a peak junction temperature of $+150^\circ\text{C}$ . |
| $R_{\theta JA}$ | Junction-to-Ambient | 62.5 |                           | 1 cubic foot chamber, free air.   |



# FTP18N20R

## OFF Characteristics $T_C=25^\circ\text{C}$ unless otherwise specified

| Symbol     | Parameter                         | Min. | Typ. | Max. | Units   | Test Conditions                                     |
|------------|-----------------------------------|------|------|------|---------|---|
| $BV_{DSS}$ | Drain-to-Source Breakdown Voltage | 200  | --   | --   | V       | $V_{GS}=0V, I_D=250\mu A$                           |
| $I_{DSS}$  | Drain-to-Source Leakage Current   | --   | --   | 1    | $\mu A$ | $V_{DS}=200V, V_{GS}=0V$<br>$T_J=25^\circ\text{C}$  |
|            |                                   | --   | --   | 100  |         | $V_{DS}=160V, V_{GS}=0V$<br>$T_J=125^\circ\text{C}$ |
| $I_{GSS}$  | Gate-to-Source Forward Leakage    | --   | --   | +100 | nA      | $V_{GS}=+30V$                                       |
|            | Gate-to-Source Reverse Leakage    | --   | --   | -100 |         | $V_{GS}=-30V$                                       |

## ON Characteristics $T_J=25^\circ\text{C}$ unless otherwise specified

| Symbol  | Parameter                            | Min. | Typ. | Max. | Units    | Test Conditions               |
|---|--------------------------------------|------|------|------|----------|-------------------------------|
| $R_{DS(ON)}$  | Static Drain-to-Source On-Resistance | --   | 0.12 | 0.18 | $\Omega$ | $V_{GS}=10V, I_D=9A$          |
| $V_{GS(TH)}$  | Gate Threshold Voltage               | 2    | --   | 4    | V        | $V_{DS}=V_{GS}, I_D=250\mu A$ |
| $g_{fs}$  | Forward Transconductance             | --   | 8.5  | --   | S        | $V_{DS}=15V, I_D=9A$          |
| Pulse width $\leq 300\mu s$ ; duty cycle $\leq 2\%$ |                                      |      |      |      |          |                               |

## Dynamic Characteristics Essentially independent of operating temperature

| Symbol    | Parameter                       | Min. | Typ. | Max. | Units   | Test Conditions                              |
|-----------|---------------------------------|------|------|------|---------|--|
| $C_{iss}$ | Input Capacitance               | --   | 1136 | --   | $\mu F$ | $V_{GS}=0V, V_{DS}=25V$<br>$f=1.0\text{MHz}$ |
| $C_{oss}$ | Output Capacitance              | --   | 183  | --   |         |  |
| $C_{rss}$ | Reverse Transfer Capacitance    | --   | 16.4 | --   |         |  |
| $Q_g$     | Total Gate Charge               | --   | 20.4 | --   | nC      | $I_D=18A, V_{DD}=160V$<br>$V_{GS}=10V$       |
| $Q_{gs}$  | Gate-to-Source Charge           | --   | 6.9  | --   |         |  |
| $Q_{gd}$  | Gate-to-Drain ("Miller") Charge | --   | 7.3  | --   |         |  |

## Resistive Switching Characteristics Essentially independent of operating temperature

| Symbol       | Parameter           | Min. | Typ. | Max. | Units | Test Conditions                                    |
|--------------|---------------------|------|------|------|-------|--|
| $t_{d(ON)}$  | Turn-on Delay Time  | --   | 19   | --   | ns    | $V_{DD}=100V, I_D=18A,$<br>$V_G=10V, R_G=10\Omega$ |
| $t_{rise}$   | Rise Time           | --   | 33   | --   |       |  |
| $t_{d(OFF)}$ | Turn-Off Delay Time | --   | 35   | --   |       |  |
| $t_{fall}$   | Fall Time           | --   | 8    | --   |       |  |



# FTP18N20R

## Source-Drain Diode Characteristics $T_c=25^\circ\text{C}$ unless otherwise specified

| Symbol  | Parameter                                 | Min. | Typ. | Max. | Units | Test Conditions                              |
|---|---|------|------|------|-------|--|
| $I_S$   | Continuous Source Current<br>(Body Diode) | --   | --   | 18   | A     | $T_c=25^\circ\text{C}$                       |
| $I_{SM}$  | Maximum Pulsed Current<br>(Body Diode)    | --   | --   | 72   | A     |  |
| $V_{SD}$  | Diode Forward Voltage                     | --   | --   | 1.5  | V     | $I_{SD}=18\text{A}, V_{GS}=0\text{V}$        |
| $t_{rr}$  | Reverse Recovery Time                     | --   | 187  | --   | ns    | $I_F=I_S$<br>$di/dt=100\text{A}/\mu\text{s}$ |
| $Q_{rr}$  | Reverse Recovery Charge                   | --   | 925  | --   | nC    |  |
| Pulse width $\leq 300\mu\text{s}$ ; duty cycle $\leq 2\%$ |   |      |      |      |       |  |

### Notes:

- \*1. Repetitive rating; pulse width limited by maximum junction temperature.
- \*2.  $L=10\text{mH}$ ,  $I_D=10\text{A}$ , Start  $T_J=25^\circ\text{C}$
- \*3.  $I_{SD}=18\text{A}$ ,  $di/dt \leq 100\text{A}/\mu\text{s}$ ,  $V_{DD} \leq BV_{DS}$ , Start  $T_J=25^\circ\text{C}$

## Characteristics Curve:

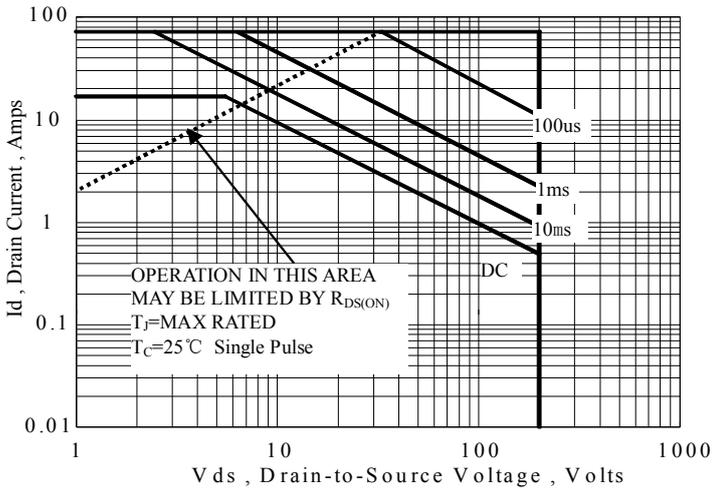


Figure 1 Maximum Forward Bias Safe Operating Area

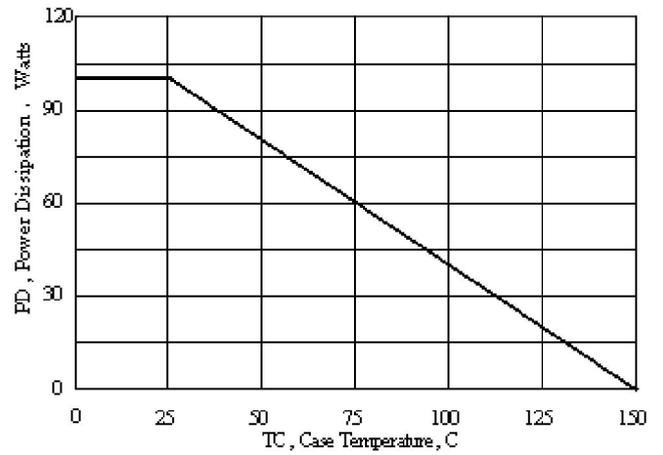


Figure 2 Maximum Power Dissipation vs Case Temperature

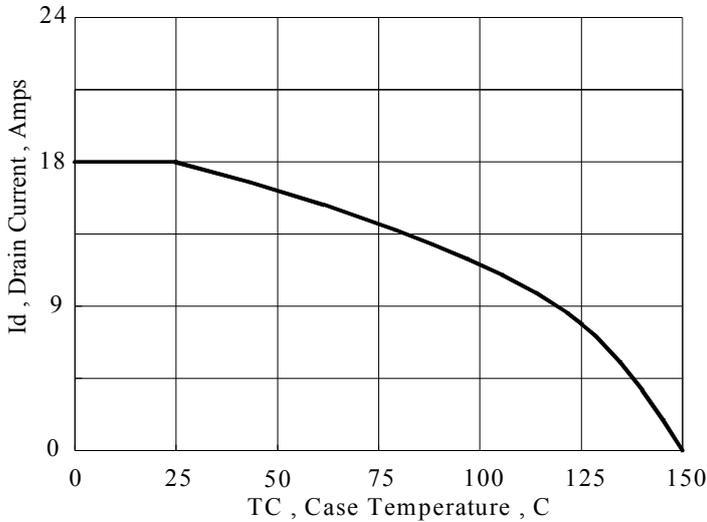


Figure 3 Maximum Continuous Drain Current vs Case Temperature

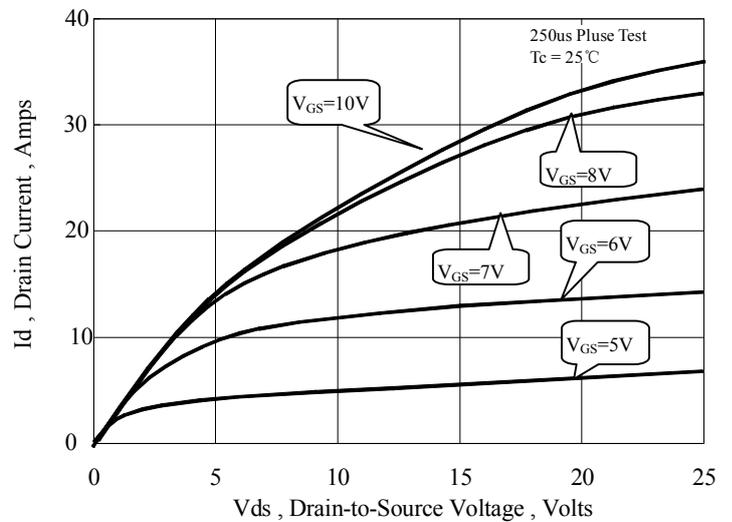


Figure 4 Typical Output Characteristics

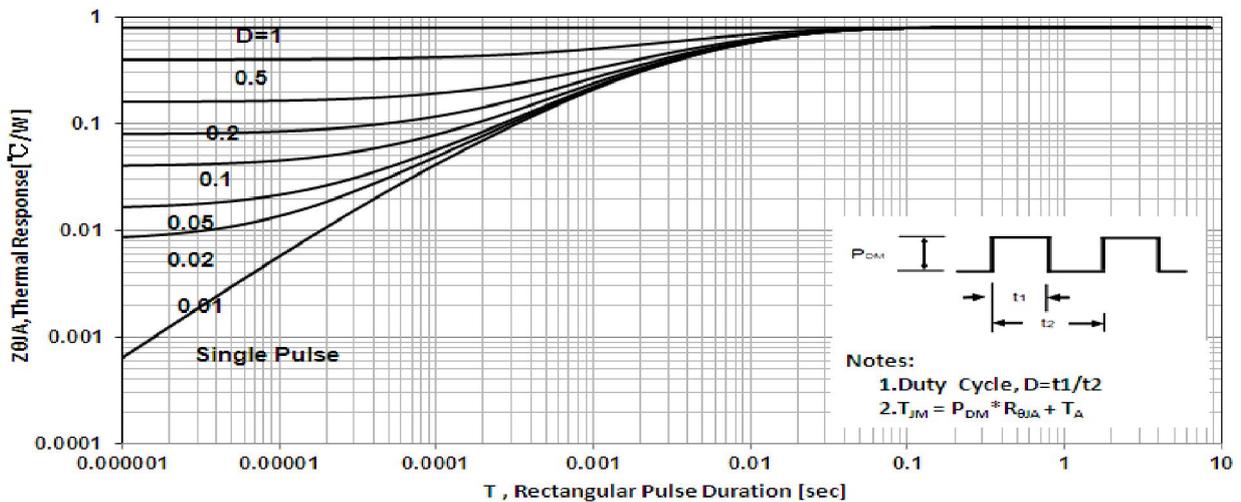
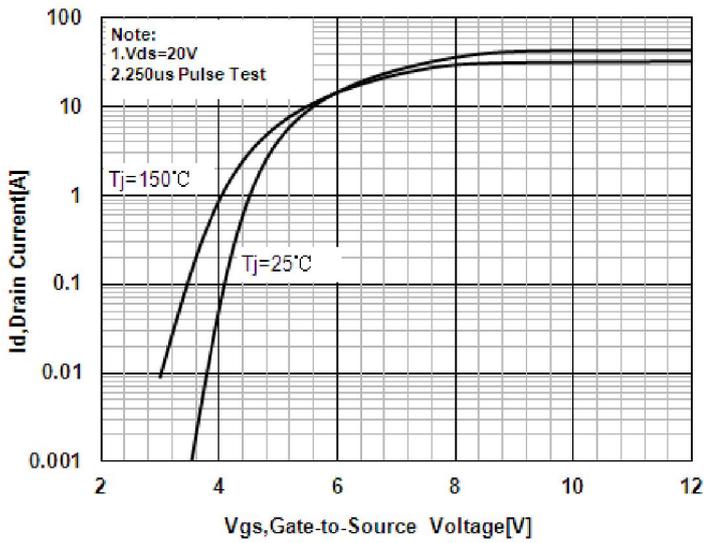
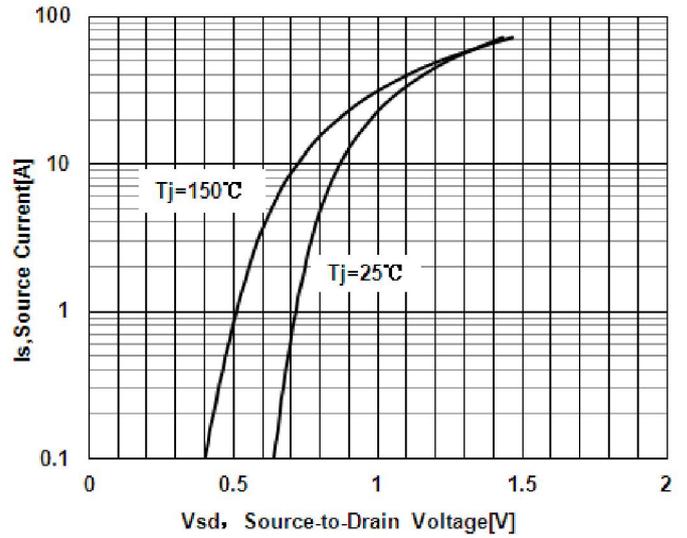


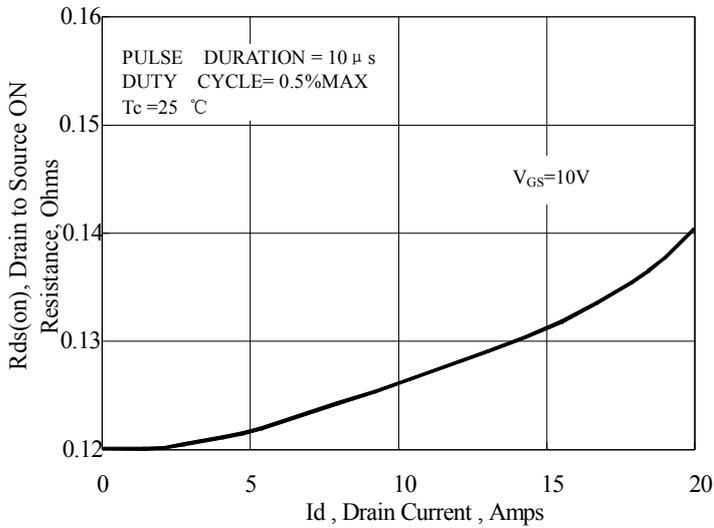
Figure 5 Maximum Effective Thermal Impedance, Junction to Case



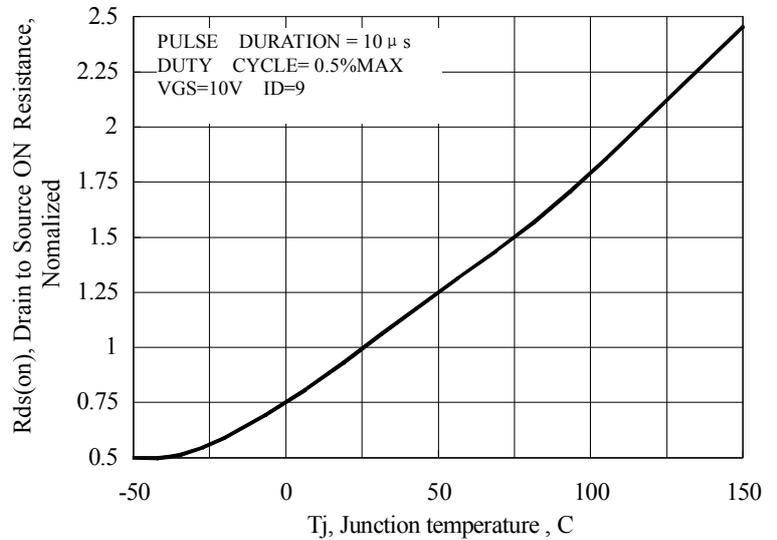
**Figure 6 Typical Transfer Characteristics**



**Figure 7 Typical Body Diode Transfer Characteristics**



**Figure 8 Typical Drain to Source ON Resistance vs Drain Current**



**Figure 9 Typical Drain to Source on Resistance vs Junction Temperature**

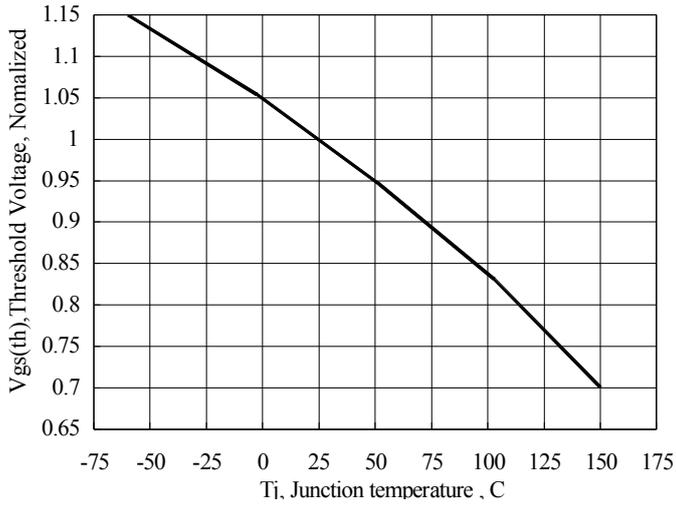


Figure 10 Typical Theshold Voltage vs Junction Temperature

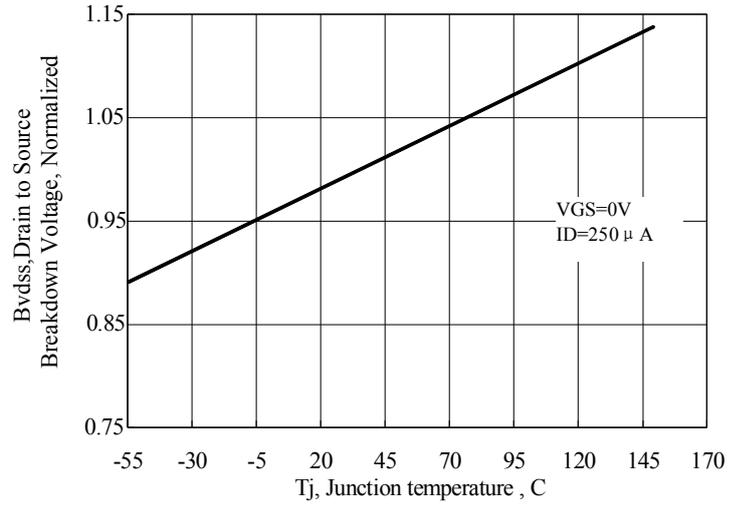


Figure 11 Typical Breakdown Voltage vs Junction Temperature

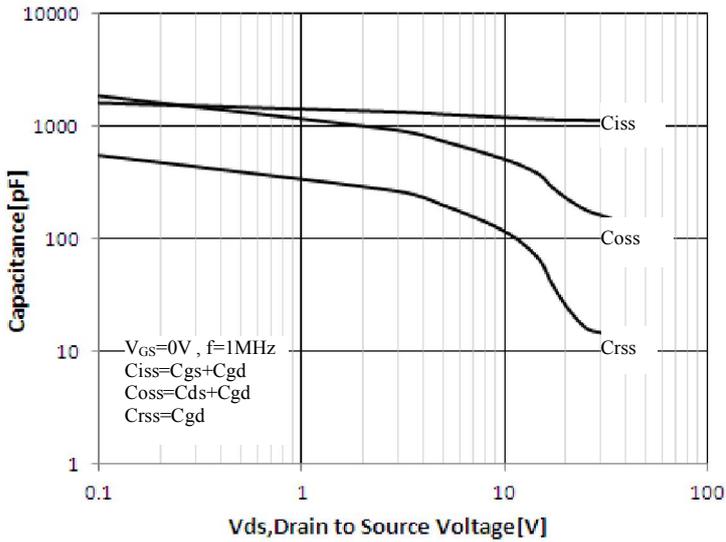


Figure 12 Typical Capacitance vs Drain to Source Voltage

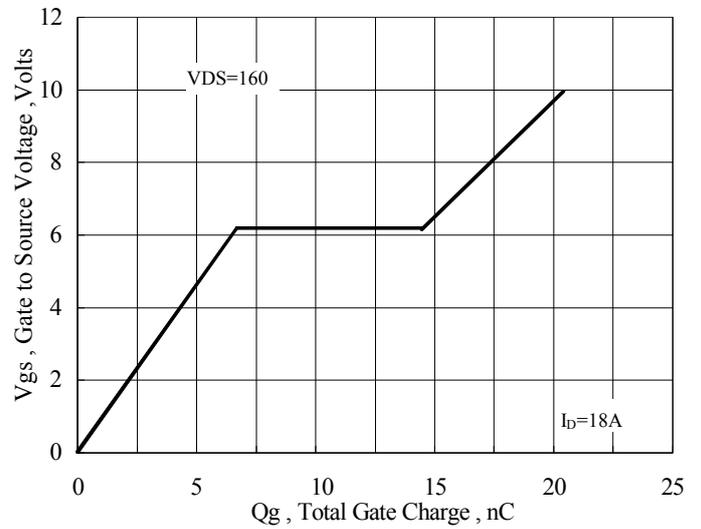


Figure 13 Typical Gate Charge vs Gate to Source Voltage

## Test Circuits and Waveforms

Figure 14. Gate Charge Test Circuit

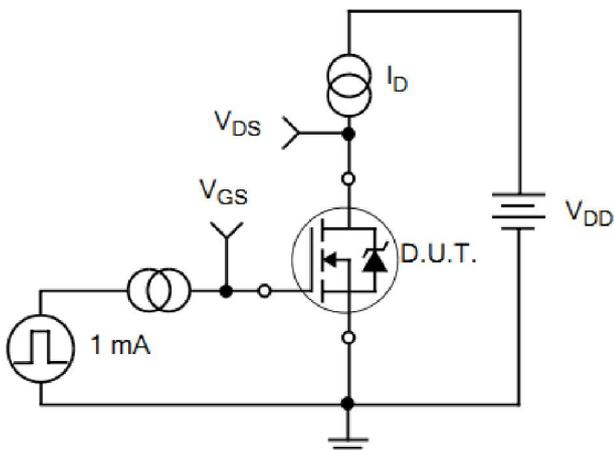


Figure 15. Gate Charge Waveforms

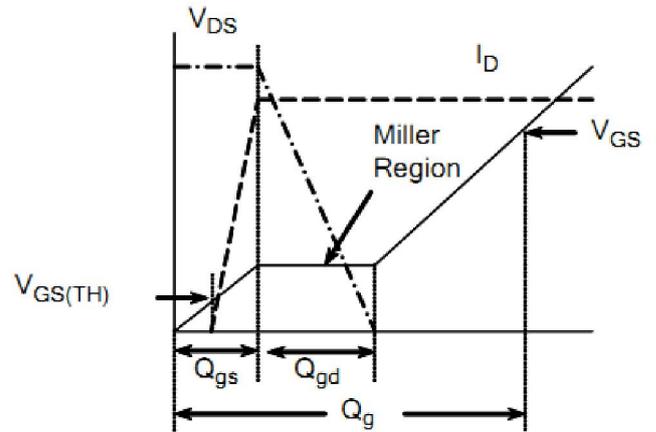


Figure 16. Resistive Switching Test Circuit

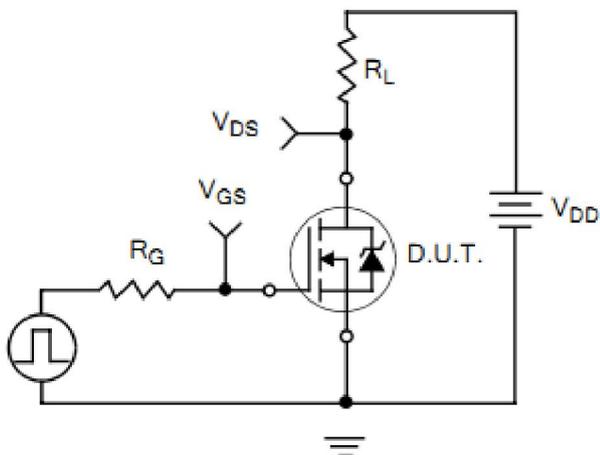


Figure 17. Resistive Switching Waveforms

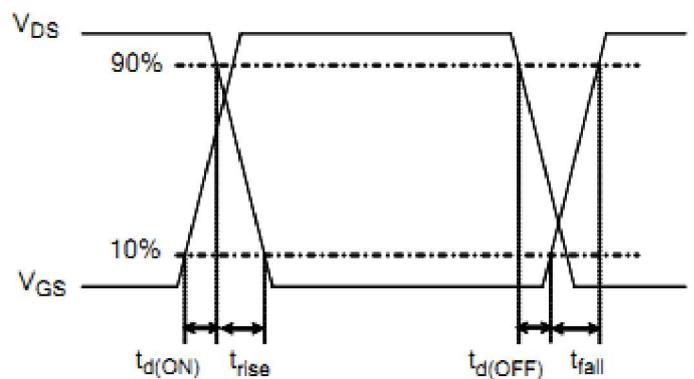


Figure 18. Diode Reverse Recovery Test Circuit

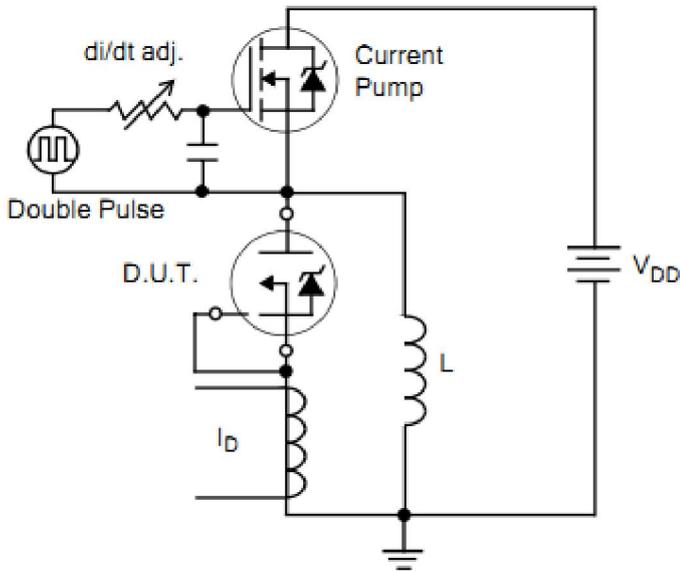


Figure 19. Diode Reverse Recovery Waveform

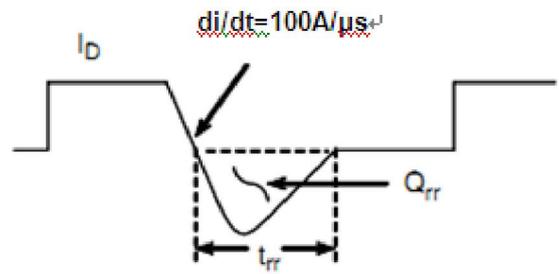


Figure20.Unclamped Inductive Switching Test Circuit

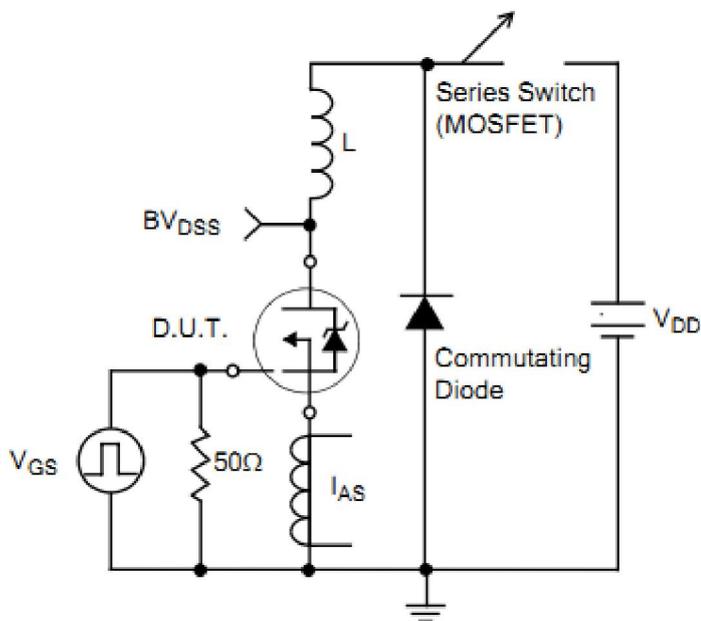
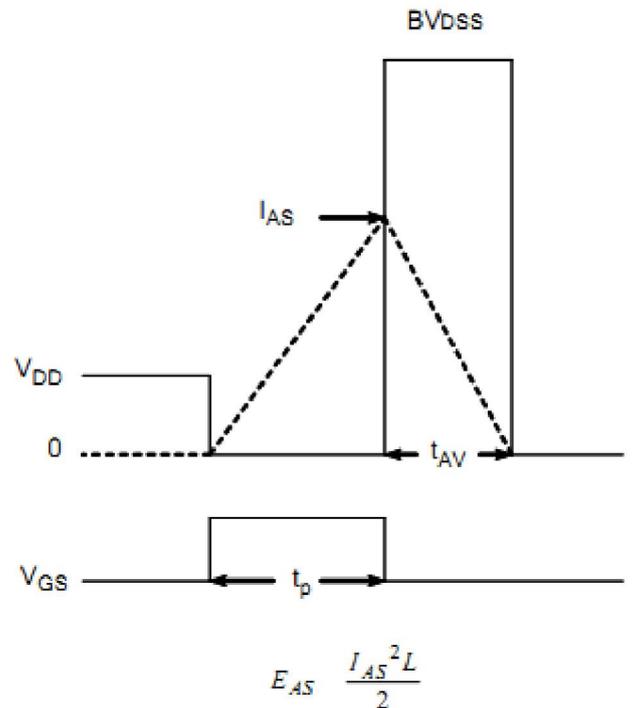


Figure21.Unclamped Inductive Switching Waveform





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